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Applicant : Yu Yamazaki et al.
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Title : LIGHT EMITTING DEVICE

Art Unit : 2815
Examiner : Joseph H Nguyen

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INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Respectfully submitted,

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Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-182001	Application No. 10/724,872
Information Disclosure Statement by Applicant JAN 17 2006 <small>(Use several sheets if necessary)</small> <small>(37 CFR §1.98(b))</small>		Applicant Yu Yamazaki et al.		
		Filing Date December 2, 2003	Group Art Unit 2815	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	2002-0044782	04/18/2002	Kota et al.			10/12/2001
	AB	2004-0245918	12/09/2004	Lee			05/21/2004
	AC	2004-0251823	12/16/2004	Park et al.			05/20/2004
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Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Sub-class	Translation
							Yes No
	AG	EP0 881 617	02 DEC 1998	EUROPE			In English
	AH	JP01-253791	11 OCT 1989	JAPAN			Abstract
	AI	JP02-134696	23 MAY 1990	JAPAN			Abstract
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	AR	JP2002-343564	29 NOV 2002	JAPAN			Abstract
	AS	WO99-018590	15 APR 1999	WIPO / PCT			In English

Other Documents (include Author, Title, Date, and Place of Publication)							
Examiner Initial	Desig. ID	Document					
	AT						
	AU						

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	